

LED CHARACTERISTICS ($T_A = 25^\circ C$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
*Reverse Leakage Current ($V_R = 3.0 V$, $R_L = 1.0 M\Omega$)	I_R	—	0.05	100	μA
*Forward Voltage ($I_F = 50 mA$)	V_F	—	1.2	1.5	Volts
Capacitance ($V_R = 0 V$, $f = 1.0 MHz$)	C	—	150	—	pF

PHOTOTRANSISTOR CHARACTERISTICS ($T_A = 25^\circ C$ and $I_F = 0$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
*Collector-Emitter Dark Current ($V_{CE} = 10 V$, Base Open) 4N25, 4N26, 4N27 4N28	I_{CEO}	—	3.5	50	nA
*Collector Base Dark Current ($V_{CB} = 10 V$, Emitter Open)	I_{CBO}	—	—	20	nA
*Collector-Base Breakdown Voltage ($I_C = 100 \mu A$, $I_E = 0$)	BV_{CBO}	70	—	—	Volts
*Collector-Emitter Breakdown Voltage ($I_C = 1.0 mA$, $I_B = 0$)	BV_{CEO}	30	—	—	Volts
*Emitter-Collector Breakdown Voltage ($I_E = 100 \mu A$, $I_B = 0$)	BV_{ECO}	7.0	—	—	Volts
DC Current Gain ($V_{CE} = 5.0 V$, $I_C = 500 \mu A$)	h_{FE}	—	250	—	—

COUPLED CHARACTERISTICS ($T_A = 25^\circ C$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
*Collector Output Current (1) ($V_{CE} = 10 V$, $I_F = 10 mA$, $I_B = 0$) 4N25, 4N26 4N27, 4N28	I_C	2.0 1.0	5.0 3.0	—	mA
*Isolation Voltage (2) 4N25 4N26, 4N27 4N28	V_{ISO}	2500 1500 500	—	—	Volts
Isolation Resistance (2) ($V = 500 V$)			10^{11}	—	Ohms
*Collector-Emitter Saturation ($I_C = 2.0 mA$, $I_F = 50 mA$)	$V_{CE(sat)}$		0.2	0.5	Volts
Isolation Capacitance (2) ($V = 0$, $f = 1.0 MHz$)			1.3	—	pF
Bandwidth (3) ($I_C = 2.0 mA$, $R_L = 100 \Omega$, Figure 11)			300	—	kHz

SWITCHING CHARACTERISTICS

Delay Time	4N25, 4N26 ($I_C = 10 \mu A$, $V_{CC} = 10 V$)	t_d	—	0.07 0.10	—	μs
Rise Time	Figures 6 and 8 4N25, 4N26 4N27, 4N28	t_r	—	0.8 2.0	—	μs
Storage Time	4N25, 4N26 ($I_C = 10 mA$, $V_{CC} = 10 V$)	t_s	—	4.0 2.0	—	μs
Fall Time	Figures 7 and 8 4N25, 4N26 4N27, 4N28	t_f	—	7.0 3.0	—	μs

*Indicates JEDEC Registered Data. (1) Pulse Test, Pulse Width = 300 μs , Duty Cycle = 20%.

(2) For this test LED pins 1 and 2 are common and Photo Transistor pins 4, 5 and 6 are common.

(3) I_F adjusted to yield $I_C = 2.0 mA$ and $I_C = 2.0 mA$ at 10 kHz.

DC CURRENT TRANSFER CHARACTERISTICS

FIGURE 2 - 4N25, 4N26

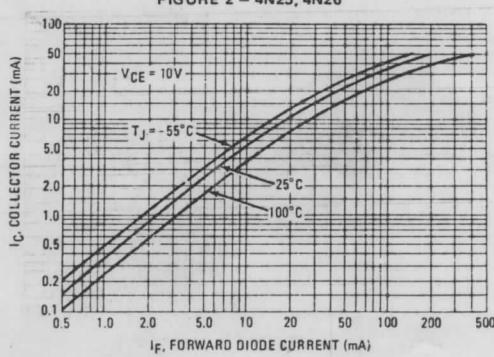
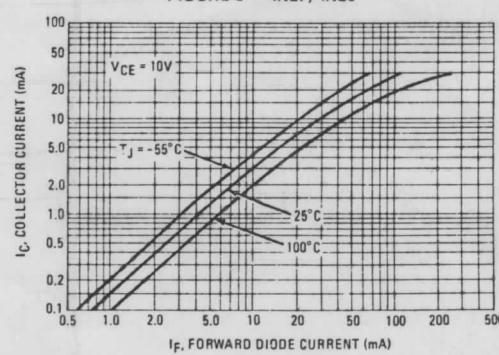


FIGURE 3 - 4N27, 4N28



TYPICAL ELECTRICAL CHARACTERISTICS

FIGURE 4 - DIODE FORWARD CHARACTERISTICS

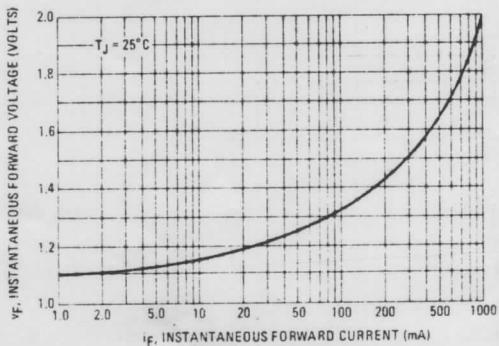


FIGURE 5 - COLLECTOR SATURATION VOLTAGE

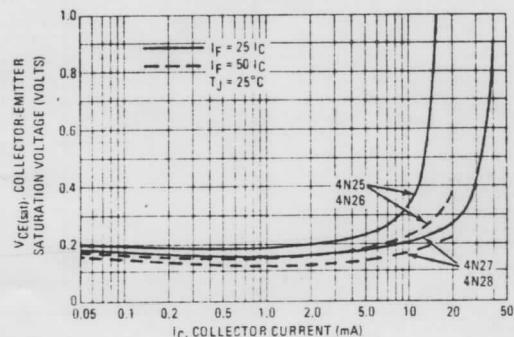


FIGURE 6 - TURN-ON TIME

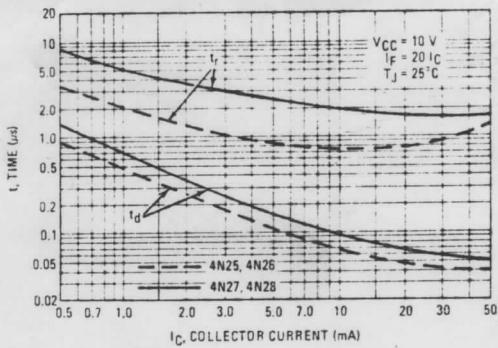


FIGURE 7 - TURN-OFF TIME

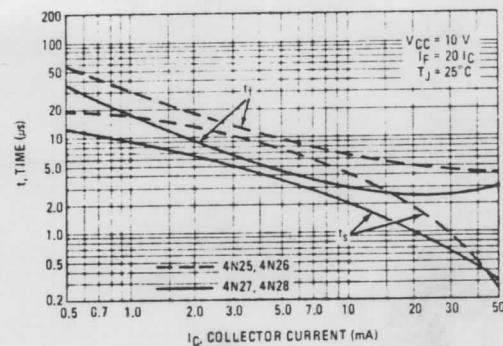


FIGURE 8 - SATURATED SWITCHING TIME TEST CIRCUIT

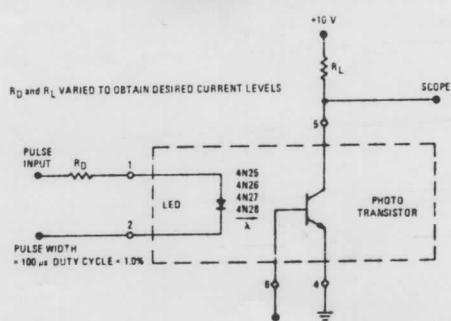
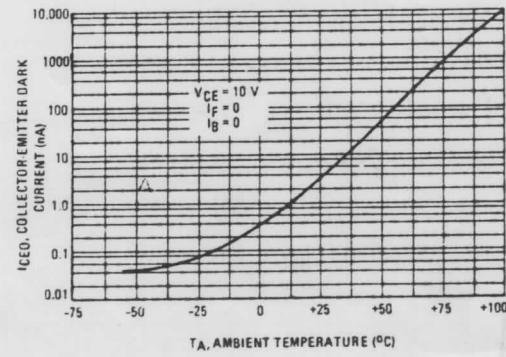


FIGURE 9 - DARK CURRENT versus AMBIENT TEMPERATURE



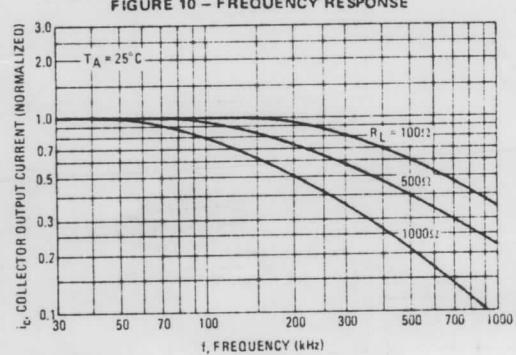
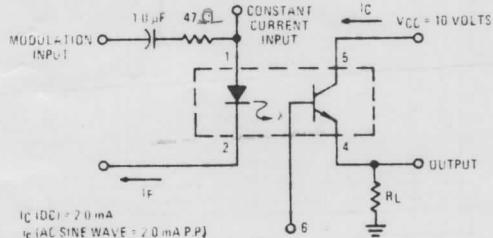


FIGURE 11 – FREQUENCY RESPONSE TEST CIRCUIT



TYPICAL APPLICATIONS

FIGURE 12 – ISOLATED MTTL TO MOS (P-CHANNEL) LEVEL TRANSLATOR

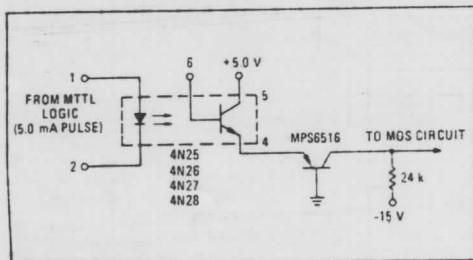


FIGURE 13 – COMPUTER/PERIPHERAL INTERCONNECT

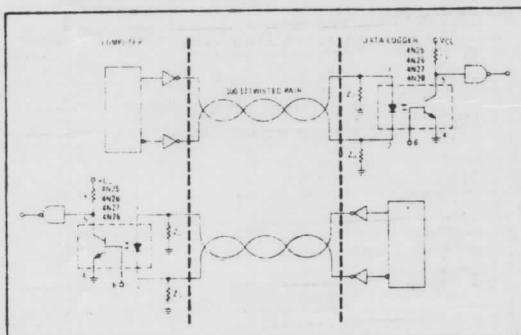


FIGURE 14 – POWER AMPLIFIER

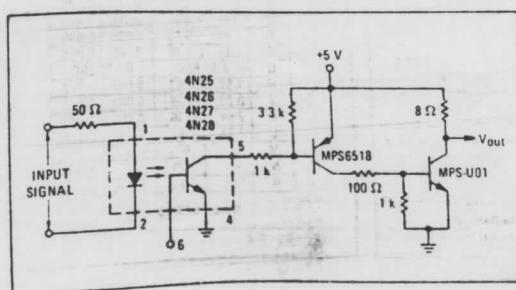
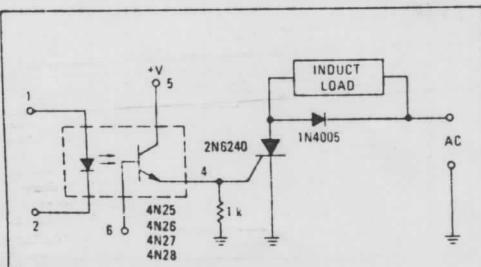


FIGURE 15 – INTERFACE BETWEEN LOGIC AND LOAD



Typical Electrical Characteristics

4N35
4N36
4N37

Electrical Characteristics—Input Diode $T_A = 25^\circ\text{C}$

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
V_F^* I_R^* C	Forward Voltage Reverse Leakage Current Capacitance	0.8	0.01	1.5 10 100	V μA pF	$I_F = 10 \text{ mA}$ $V_R = 6.0 \text{ V}$ $V_R = 0 \text{ V}$ $f = 1 \text{ MHz}$

Electrical Characteristics—Output Transistor $T_A = 25^\circ\text{C}$

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
V_{CEO}^* V_{CBO}^* V_{ECO}^*	Collector-to-Emitter Voltage Collector-to-Base Voltage Emitter-to-Collector Voltage	30 70 7.0	65 165 14		V	$I_C = 10 \text{ mA}$ $I_C = 100 \mu\text{A}$ $I_E = 100 \mu\text{A}$ $I_F = 0$ $V_{CE} = 10 \text{ V}$ $V_{CE} = 30 \text{ V}$ $I_F = 0$ $T_A = 100^\circ\text{C}$ $V_{CE} = 5.0 \text{ V}$ $I_C = 100 \mu\text{A}$ $V_{CB} = 10 \text{ V}$
I_{CEO}^*	Collector-to-Emitter Leakage Current		5.0	50	nA	
I_{CEO}^*	Collector-to-Emitter Leakage Current			500	μA	
h_{FE}	Forward Current Gain	100	250			
C_{cb}	Collector-to-Base Capacitance			25	pF	

Electrical Characteristics—Coupled $T_A = 25^\circ\text{C}$

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
I_{IO}^*	Input-to-Output Current 4N35 4N36 4N37			100 100 100 0.3	μA	$PW = 8 \text{ ms}$ $V_{IO} = 3550 \text{ V}$ $V_{IO} = 2500 \text{ V}$ $V_{IO} = 1500 \text{ V}$ $I_C = 0.5 \text{ mA}$ $I_F = 10 \text{ mA}$
$V_{CE(sat)}^*$	Collector-to-Emitter Saturation Voltage	100			%	$V_{CE} = 10 \text{ V}$ $I_F = 10 \text{ mA}$
$I_C/I_F(\text{CTR})^*$	Collector Current Transfer Ratio (Note)	40			%	$V_{CE} = 10 \text{ V}$ $I_F = 10 \text{ mA}$
R_{IO} C_{IO}	Input-to-Output Resistance Input-to-Output Capacitance		10 ¹¹	1.0 5.0	Ω μs	$V_{IO} = 500 \text{ V}$ $V_{IO} = 0$ $f = 1.0 \text{ MHz}$ $I_C = 2.0 \text{ mA}$ $V_{CC} = 10 \text{ V}$ $R_L = 100 \Omega$ $I_C = 2.0 \text{ mA}$ $V_{CC} = 10 \text{ V}$ $R_L = 100 \Omega$
t_{on}	Turn-on Time			5.0	μs	
t_{off}	Turn-off Time			5.0	μs	

Notes

Collector current transfer ratio is defined as the ratio of the collector current to the forward bias input current.

*Indicates JEDEC registered values.

LSTTL/T Optocoupler

Optoelectronic Pr

General Description
The 6N137 optocoupler consists of an infrared emitting diode and a photo-transistor. The light emitted by the diode is collected in the photo-transistor. The output is amplified by a high-gain Schottky-clamped transistor. The operating temperature, current, and voltage ratings are listed in the following table.

This isolator design provides high isolation between the input and output stages while maintaining a low input current. The output current is 5 mA. The isolating mode, the output is an LSTTL/TTL-compatible level. The output is gated by the input signal.

The 6N137 is an optocoupler designed for use in subsystems that require high common-mode noise immunity. The programmable logic controller, other machine control, and data acquisition systems.

LSTTL/TTL Compatible
Ultra High Speed
Low Input Current
High Common-Mode
Guaranteed Per
3000 V dc Insulation

Absolute Maximum Ratings
Up to 70°C

Maximum Temperature
Operating Temperature
Storage Temperature
Pin Temperature
(1.6 mm below surface)

Maximum Power
Output Collector
Dissipation

*JEDEC Registered

Optically-Coupled Isolator

Optoelectronic Products

4N35
4N36
4N37

General Description

The 4N35, 4N36 and 4N37 series of optoisolators has a silicon npn Planar phototransistor in close proximity to a GaAs diode. Optical coupling provides a high degree of ac and dc isolation. A capability for continuous operation of the input diode results in a frequency response extending to dc. Connection to the transistor base is also provided for design flexibility. This isolator series is covered under UL component recognition program, reference file E55299.

Glassolated™

High Current Transfer Ratio—Minimum 100%
1500 V to 3500 V Minimum Isolation

Input-to-Output

$10^{11} \Omega$ Isolation Resistance

Low Coupling Capacitance—Typically 1.0 pF

Test Conditions

$I_E = 100 \mu A$,
 $I_F = 0$,
 $I_{PD} = 100 \mu A$,
 $I_C = 0$,
 $I_{CE} = 100 \mu A$,
 $I_E = 0$,
 $V_{CE} = 10 V$,
Base Open
 $V_{CE} = 5.0 V$,
 $I_E = 500 \mu A$

Test Conditions

$V_E = 10 V$,
 $I_E = 10 mA$,
 $V_E = 10 V$,
 $I_E = 10 mA$,
 $V_E = 10 V$,
 $I_E = 10 mA$

$V_E = 500 V$,
 $I_E = 2.0 mA$,
 $I_E = 8.0 mA$,
 $I_E = 2.0 mA$,
 $I_E = 8.0 mA$,
 $I_E = 0$,
 $I_E = 1.0 MHz$,
 $I_E = 50 mA$,
 $V_E = 10 V$,
 $R_E = 180 \Omega$,
 $I_E = 200 mA$,
 $I_E = 50 mA$,
 $V_E = 10 V$,
 $R_E = 180 \Omega$,
 $I_E = 200 mA$

Time required for

Absolute Maximum Ratings

Maximum Temperature and Humidity

Storage Temperature* $-55^\circ C$ to $+150^\circ C$
Operating Temperature $-55^\circ C$ to $+100^\circ C$
Pin Temperature (Soldering, 10s)* $260^\circ C$
Relative Humidity at $85^\circ C$ * 85%

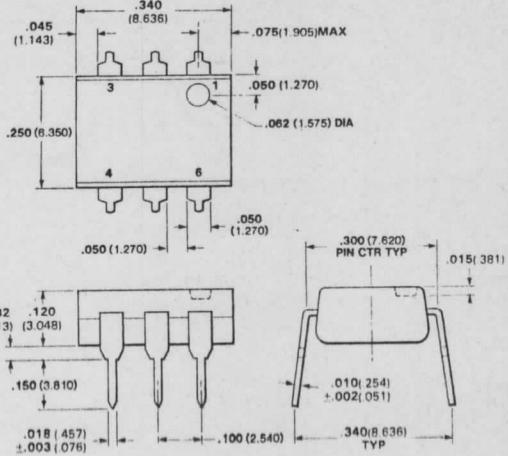
Input Diode

V_R *	Reverse Voltage	6.0 V
I_F *	Forward Current	60 mA
I_{pk} *	Peak Forward Current at 1 μs pulse width, 300 pps	3.0 A
P_D *	Power Dissipation at $T_A = 25^\circ C$	100 mW Derate Linearly from $25^\circ C$ 1.33 mW/ $^\circ C$

Output Transistor

V_{CE} *	Collector-to-Emitter Voltage	30 V
V_{CB} *	Collector-to-Base Voltage	70 V
V_{EC} *	Emitter-to-Collector Voltage	7.0 V
I_C *	Collector Current	100 mA
P_D *	Power Dissipation at $T_A = 25^\circ C$	300 mW Derate Linearly from $25^\circ C$ 4.0 mW/ $^\circ C$

Package Outline



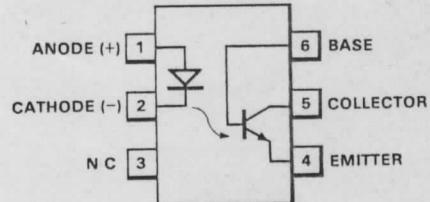
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Notes

All dimension in inches bold and millimeters (parentheses)

Tolerance unless specified = ± 0.15 (0.381)

Connection Diagram DIP (Top View)



Pin

1	Anode (+)	Input Diode
2	Cathode (-)	
3	NC	
4	Emitter	
5	Collector	Output npn Phototransistor
6	Base	

*Indicates JEDEC registered values.

TYPES TIL111, TIL114, TIL116, TIL117 OPTO-COUPERS

BULLETIN NO. DL-S 7312030, NOVEMBER 1973

COMPATABLE WITH STANDARD DTL AND TTL INTEGRATED CIRCUITS

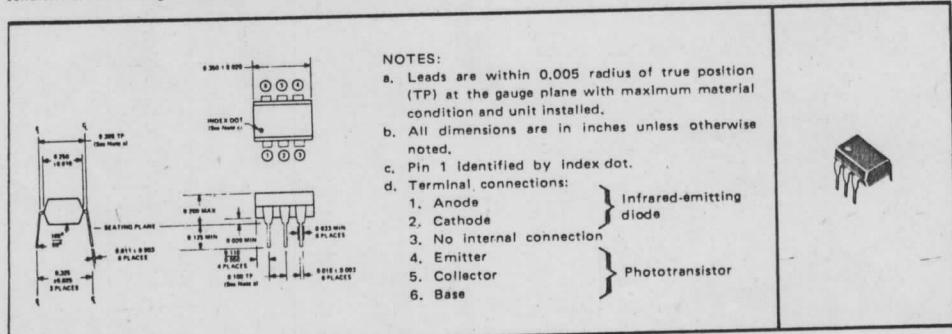
TYP	MAX	UNIT
		V
1500		μ A
500		nA
10		μ A
0.3		V
1.2	1.9	V
10^{13}		Ω

ported together.

TYP	UNIT
5	μ s
6	μ s

mechanical data

The package consists of a gallium arsenide infrared-emitting diode and an n-p-n silicon phototransistor mounted on a 6-lead frame encapsulated within an electrically nonconductive plastic compound. The case will withstand soldering temperature with no deformation and device performance characteristics remain stable when operated in high-humidity conditions. Unit weight is approximately 0.52 grams.



absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)

Input-to-Output Voltage: TIL111	±1.5 kV
TIL114, TIL116, TIL117	±2.5 kV
Collector-Base Voltage	70 V
Collector-Emitter Voltage (See Note 1)	30 V
Emitter-Collector Voltage	7 V
Emitter-Base Voltage	3 V
Input-Diode Reverse Voltage	100 mA
Input-Diode Continuous Forward Current at (or below) 25°C Free-Air Temperature (See Note 2)	100 mA
Continuous Power Dissipation at (or below) 25°C Free-Air Temperature:	
Infrared-Emitting Diode (See Note 3)	150 mW
Phototransistor (See Note 4)	150 mW
Total, Infrared-Emitting Diode plus Phototransistor (See Note 5)	250 mW
Storage Temperature Range	-55°C to 150°C
Lead Temperature 1/16 Inch from Case for 10 Seconds	260°C

NOTES: 1. This value applies when the base-emitter diode is open-circuited.
2. Derate linearly to 100°C free-air temperature at the rate of 1.33 mA/°C.
3. Derate linearly to 100°C free-air temperature at the rate of 2 mW/°C.
4. Derate linearly to 100°C free-air temperature at the rate of 2 mW/°C.
5. Derate linearly to 100°C free-air temperature at the rate of 3.33 mW/°C.

w = 50 μ s, duty

2, C_{in} < 20 pF.

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TYPES TIL111, TIL114, TIL116, TIL117 OPTO-COUPERS

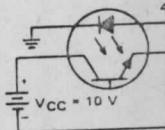
electrical characteristics at 25°C free-air temperature

PARAMETER	TEST CONDITIONS	TIL111			TIL116			TIL117			UNIT
		MIN	Typ	MAX	MIN	Typ	MAX	MIN	Typ	MAX	
$V_{(BR)CBO}$	Collector-Base Breakdown Voltage	$I_C = 10 \mu A$, $I_E = 0$, $I_F = 0$	70		70		70		70		V
$V_{(BR)CEO}$	Collector-Emitter Breakdown Voltage	$I_C = 1 \text{ mA}$, $I_B = 0$, $I_F = 0$	30		30		30		30		V
$V_{(BR)EBO}$	Emitter-Base Breakdown Voltage	$I_E = 10 \mu A$, $I_C = 0$, $I_F = 0$	7		7		7		7		V
I_R	Input Diode Static Reverse Current	$V_R = 3 \text{ V}$			10		10		10		μA
$I_{C(on)}$	On-State Collector Current	$V_{CE} = 0.4 \text{ V}$, $I_F = 16 \text{ mA}$, $I_B = 0$	2	7							mA
		$V_{CE} = 10 \text{ V}$, $I_F = 10 \text{ mA}$, $I_B = 0$			2	5		5	9		
	Photodiode Operation	$V_{CB} = 0.4 \text{ V}$, $I_F = 16 \text{ mA}$, $I_E = 0$	10	20	10	20		10	20		μA
$I_{C(off)}$	Off-State Collector Current	$V_{CE} = 10 \text{ V}$, $I_F = 0$, $I_B = 0$		1	50		1	50		1	50
		$V_{CB} = 10 \text{ V}$, $I_F = 0$, $I_E = 0$		0.1	20		0.1	20		0.1	20
h_{FE}	Transistor Static Forward Current Transfer Ratio	$V_{CE} = 5 \text{ V}$, $I_C = 10 \text{ mA}$, $I_F = 0$	100	300				200	550		
		$V_{CE} = 5 \text{ V}$, $I_C = 100 \mu A$, $I_F = 0$			100	300					
V_F	Input Diode Static Forward Voltage	$I_F = 16 \text{ mA}$		1.2	1.4			1.2	1.4		V
		$I_F = 60 \text{ mA}$				1.25	1.5				
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C = 2 \text{ mA}$, $I_F = 16 \text{ mA}$, $I_B = 0$		0.25	0.4						V
		$I_C = 2.2 \text{ mA}$, $I_F = 15 \text{ mA}$, $I_B = 0$				0.25	0.4				
		$I_C = 0.5 \text{ mA}$, $I_F = 10 \text{ mA}$, $I_B = 0$						0.25	0.4		
r_{IO}	Input-to-Output Internal Resistance	$V_{in-out} = \pm 1.5 \text{ kV}$ for TIL111, $\pm 2.5 \text{ kV}$ for all others, See Note 6	10^{11}		10^{11}		10^{11}		10^{11}		Ω
C_{IO}	Input-to-Output Capacitance	$V_{in-out} = 0$, $f = 1 \text{ MHz}$, See Note 6		1	1.3		1	1.3		1	pF

NOTE 6: These parameters are measured between both input-diode leads shorted together and all the phototransistor leads shorted together.

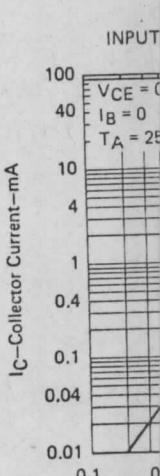
switching characteristics at 25°C free-air temperature

PARAMETER	TEST CONDITIONS	TIL111			TIL116			TIL117			UNIT
		MIN	Typ	MAX	MIN	Typ	MAX	MIN	Typ	MAX	
t_r	Rise Time	$V_{CC} = 10 \text{ V}$, $I_{C(on)} = 2 \text{ mA}$, $R_L = 100 \Omega$, See Test Circuit A of Figure 1	2	5		2	7		2	9	μs
			2	5		2	7		2	9	
t_f	Fall Time	$V_{CC} = 10 \text{ V}$, $I_{C(on)} = 20 \mu A$, $R_L = 1 \text{ k}\Omega$, See Test Circuit B of Figure 1	1		1		1		1		μs
			1		1		1		1		



TEST CIRCUIT
PHOTOTRANSISTOR

NOTES: a. The input
 $t_w = 100 \mu s$
b. The output

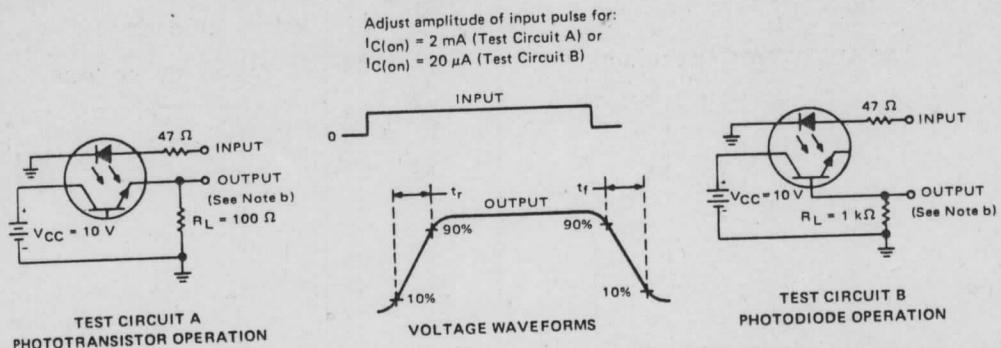


TYPES TIL111, TIL114, TIL116, TIL117 OPTO-COUPLED

PARAMETER MEASUREMENT INFORMATION

MAX	UNIT
V	V
V	V
10	μ A
mA	mA
μ A	μ A
50	nA
20	
1.4	V
0.4	V
1.3	Ω
0.01	pF

AX	UNIT
9	μ s
9	μ s
0.01	μ s



NOTES: a. The input waveform is supplied by a generator with the following characteristics: $Z_{out} = 50 \Omega$, $t_r \leq 15 \text{ ns}$, duty cycle $\approx 1\%$, $t_w = 100 \mu\text{s}$.
b. The output waveform is monitored on an oscilloscope with the following characteristics: $t_r \leq 12 \text{ ns}$, $R_{in} \geq 1 \text{ M}\Omega$, $C_{in} \leq 20 \text{ pF}$.

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FIGURE 1-SWITCHING TIMES

TYPICAL CHARACTERISTICS

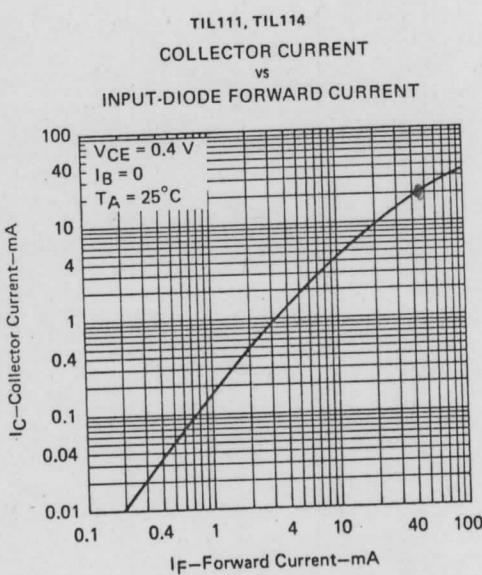


FIGURE 2

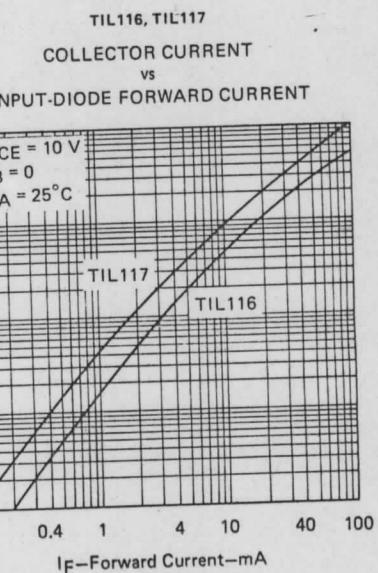
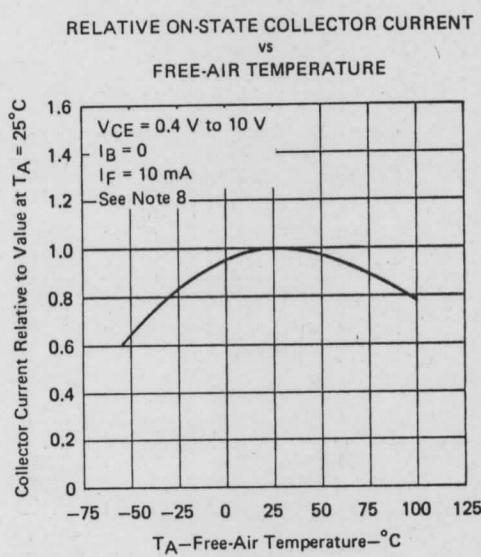
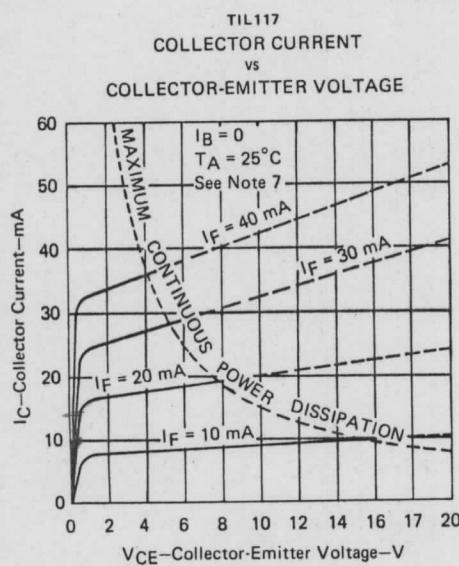
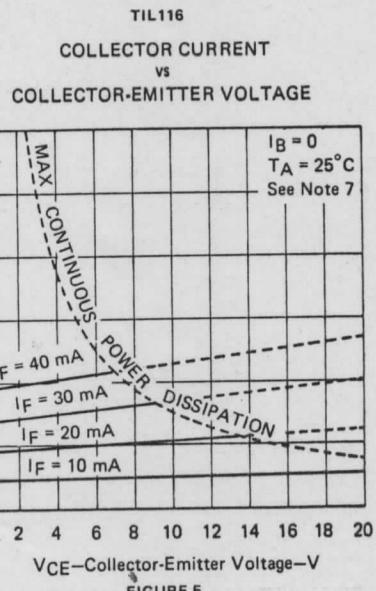
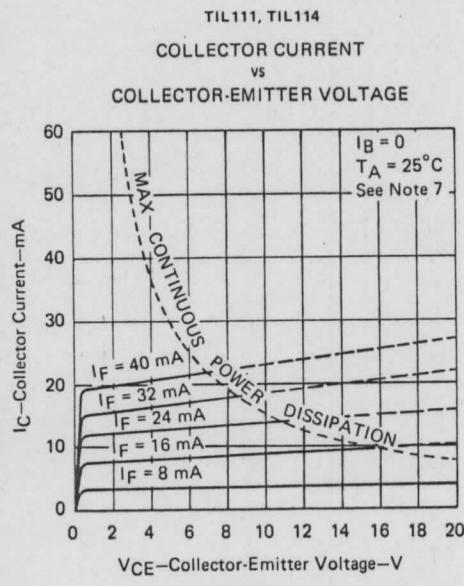


FIGURE 3

TYPES TIL111, TIL114, TIL116, TIL117 OPTO-COUPERS

TYPICAL CHARACTERISTICS



NOTES: 7. Pulse operation of input diode is required for operation beyond limits shown by dotted lines.
8. These parameters were measured using pulse techniques. $t_w = 1$ ms, duty cycle $\leq 2\%$.

TYPES TIL111, TIL114, TIL116, TIL117 OPTO-COUPERS

TYPICAL CHARACTERISTICS

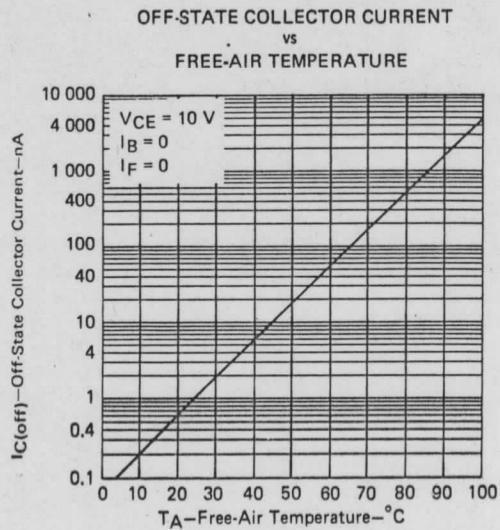


FIGURE 8

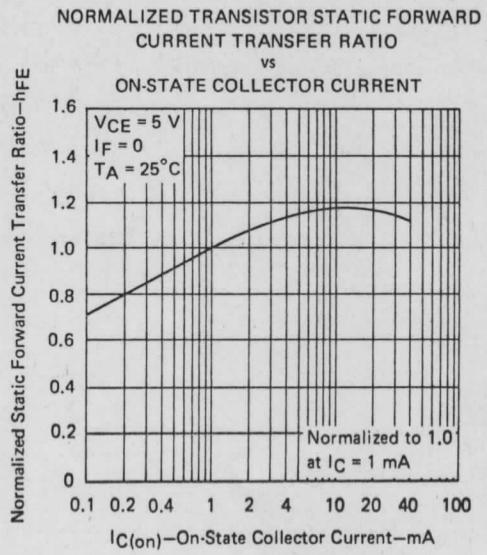


FIGURE 9

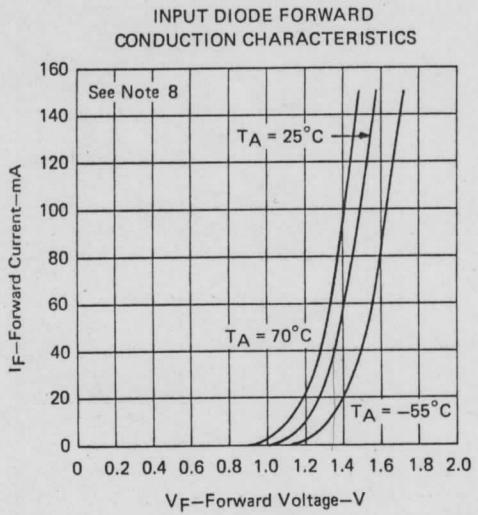


FIGURE 10

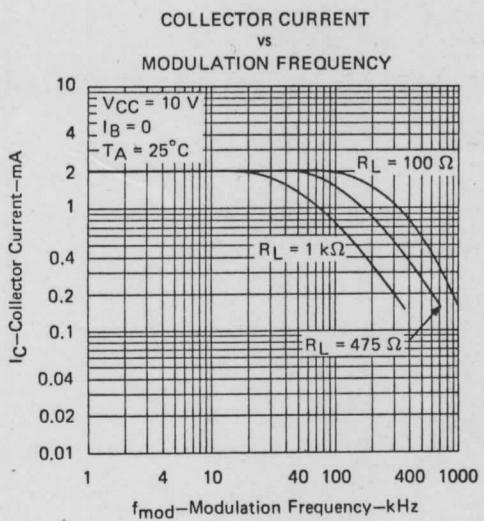


FIGURE 11

NOTE 8: These parameters were measured using pulse techniques. $t_{\text{w}} = 1$ ms, duty cycle $\leq 2\%$.

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OPTOCOUPERS

TIL112

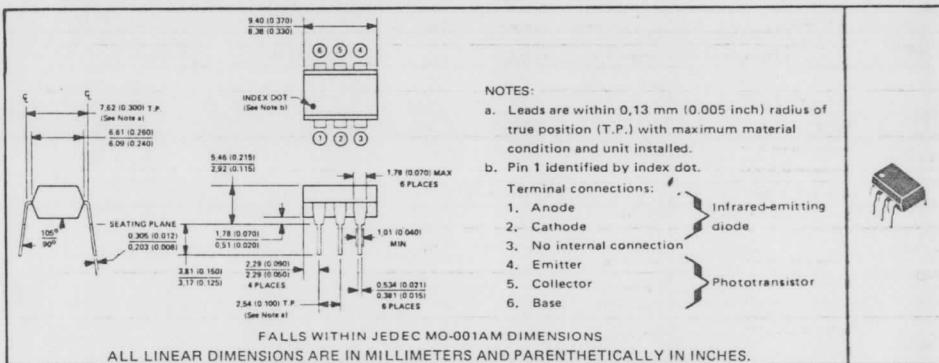
TIL115

TIL118

- Gallium Arsenide Diode Infrared Source Optically Coupled to a Silicon N-P-N Phototransistor
- High Direct-Current Transfer Ratio
- Base Lead Provided for Conventional Transistor Biasing (TIL112, TIL115)
- High-Voltage Electrical Isolation . . . 1.5-kV or 2.5-kV Rating
- Plastic Dual-In-Line Package
- High-Speed Switching: $t_r = 2 \mu s$, $t_f = 2 \mu s$ Typical

mechanical data

The package consists of a gallium arsenide infrared-emitting diode and an n-p-n silicon phototransistor mounted on a 6-lead frame encapsulated within an electrically nonconductive plastic compound. The case will withstand soldering temperature with no deformation and device performance characteristics remain stable when operated in high-humidity conditions. Unit weight is approximately 0.52 grams.



absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)

	TIL112	TIL115	TIL118
Input-to-Output Voltage	±1.5 kV	±2.5 kV	±1.5 kV
Collector-Base Voltage	30 V	30 V	20 V
Collector-Emitter Voltage (See Note 1)	20 V	20 V	20 V
Emitter-Collector Voltage	4 V	4 V	4 V
Emitter-Base Voltage	4 V	4 V	4 V
Input-Diode Reverse Voltage	3 V	3 V	3 V
Input-Diode Continuous Forward Current at (or below)			
25°C Free-Air Temperature (See Note 2)	100 mA		
Continuous Power Dissipation at (or below) 25°C Free-Air Temperature:			
Infrared-Emitting Diode (See Note 3)	150 mW		
Phototransistor (See Note 4)	150 mW		
Total (Infrared-Emitting Diode plus Phototransistor, See Note 5)	250 mW		
Storage Temperature Range	−55°C to 150°C		
Lead Temperature 1.6 mm (1/16 Inch) from Case for 10 Seconds	260°C		

NOTES: 1. This value applies when the base-emitter diode is open-circuited.
2. Derate linearly to 100°C free-air temperature at the rate of 1.33 mA/°C.
3. Derate linearly to 100°C free-air temperature at the rate of 2 mW/°C.
4. Derate linearly to 100°C free-air temperature at the rate of 2 mW/°C.
5. Derate linearly to 100°C free-air temperature at the rate of 3.33 mW/°C.

electrical characteristics at 25°C free-air temperature

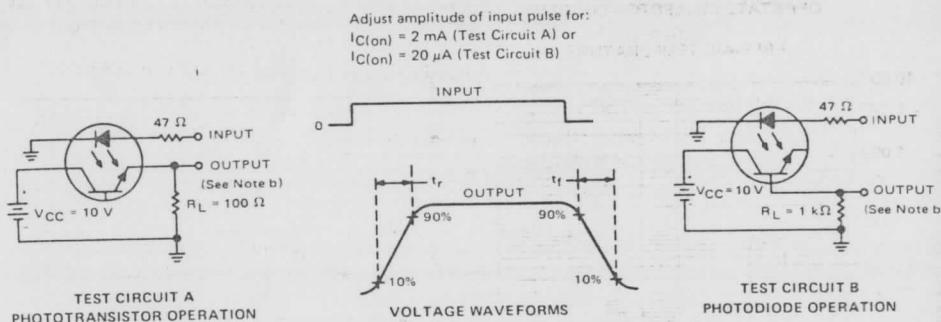
PARAMETER	TEST CONDITIONS ¹	TIL112			TIL115			TIL118			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
$V_{(BR)CBO}$ Collector-Base Breakdown Voltage	$I_C = 10 \mu A, I_E = 0, I_F = 0$	30			30						V
$V_{(BR)CEO}$ Collector-Emitter Breakdown Voltage	$I_C = 1 \text{ mA}, I_B = 0, I_E = 0, I_F = 0$	20			20			20			V
$V_{(BR)EBO}$ Emitter-Base Breakdown Voltage	$I_E = 10 \mu A, I_C = 0, I_F = 0$	4			4						V
$V_{(BR)ECO}$ Emitter-Collector Breakdown Voltage	$I_E = 10 \mu A, I_F = 0$							4			V
$I_{C(on)}$ On-State Collector Current	Phototransistor Operation Photodiode Operation	$V_{CE} = 5 \text{ V}, I_F = 10 \text{ mA}, I_E = 0$	0.2	2		0.2	2		1	2	mA
$I_{C(off)}$ Off-State Collector Current	Phototransistor Operation Photodiode Operation	$V_{CE} = 5 \text{ V}, I_F = 0, I_E = 0$	1	100		1	100		1	100	nA
h_{FE} Transistor Static Forward Current Transfer Ratio		$V_{CE} = 5 \text{ V}, I_C = 10 \text{ mA}, I_F = 0$	50	200		50	200				
V_F Input Diode Static Forward Voltage		$I_F = 10 \text{ mA}$	1.2	1.5		1.2	1.5		1.2	1.5	V
$V_{CE(sat)}$ Collector-Emitter Saturation Voltage		$I_C = 2 \text{ mA}, I_F = 50 \text{ mA}, I_B = 0$		0.5		0.5		0.5			V
R_{IO} Input-to-Output Internal Resistance		$V_{in-out} = \pm 1.5 \text{ kV}, \text{ See Note 6}$	10^{11}				10^{11}				Ω
C_{IO} Input-to-Output Capacitance		$V_{in-out} = \pm 2.5 \text{ kV}, \text{ See Note 6}$		10^{11}							
		$V_{in-out} = 0, f = 1 \text{ MHz}, \text{ See Note 6}$	1	2		1	2		1	2	pF

NOTE 6: These parameters are measured between both input-diode leads shorted together and all the phototransistor leads shorted together.
1. References to the base are not applicable for the TIL118.

switching characteristics at 25°C free-air temperature

PARAMETER	TEST CONDITIONS	TIL112			TIL115			TIL118			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
t_r Rise Time Phototransistor Operation	$V_{CC} = 10 \text{ V}, I_{C(on)} = 2 \text{ mA}, I_B = 0, R_L = 100 \Omega, \text{ See Test Circuit A of Figure 1}$	2	15		2	15		2	15		μs
t_f Fall Time Photodiode Operation		2	15		2	15		2	15		μs
t_r Rise Time Photodiode Operation	$V_{CC} = 10 \text{ V}, I_{C(on)} = 20 \mu\text{A}, I_B = 0, R_L = 1 \text{ k}\Omega, \text{ See Test Circuit B of Figure 1}$	1		1							μs
t_f Fall Time Photodiode Operation		1		1							

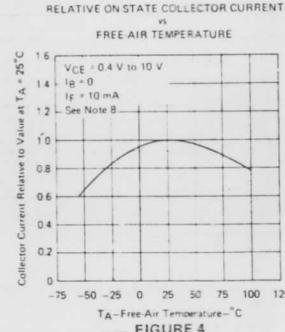
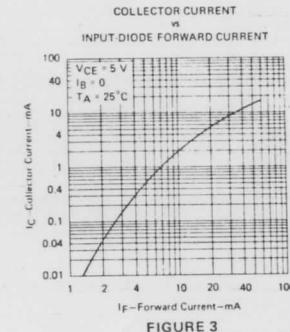
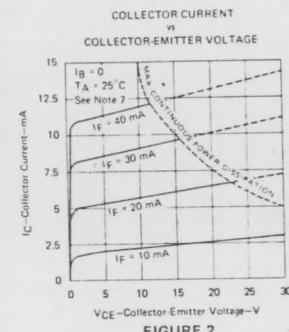
PARAMETER MEASUREMENT INFORMATION



NOTES: a. The input waveform is supplied by a generator with the following characteristics: $Z_{out} = 50 \Omega$, $t_r \leq 15 \text{ ns}$, duty cycle $\approx 1\%$, $t_w = 100 \mu\text{s}$.
b. The output waveform is monitored on an oscilloscope with the following characteristics: $t_r \leq 12 \text{ ns}$, $R_{in} \geq 1 \text{ M}\Omega$, $C_{in} \leq 20 \text{ pF}$.

FIGURE 1—SWITCHING TIMES

TYPICAL CHARACTERISTICS



NOTES: 7. Pulse operation of input diode is required for operation beyond limits shown by dotted lines.
8. These parameters were measured using pulse techniques $t_w = 1 \text{ ms}$, duty cycle $\leq 2\%$.

TYPICAL CHARACTERISTICS

OFF-STATE COLLECTOR CURRENT
vs
FREE-AIR TEMPERATURE

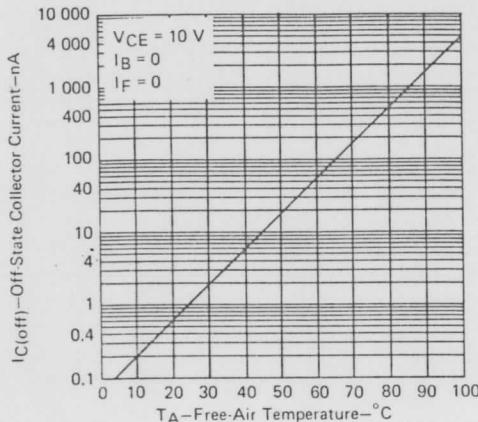


FIGURE 5

NORMALIZED TRANSISTOR STATIC FORWARD
CURRENT TRANSFER RATIO
vs

ON-STATE COLLECTOR CURRENT

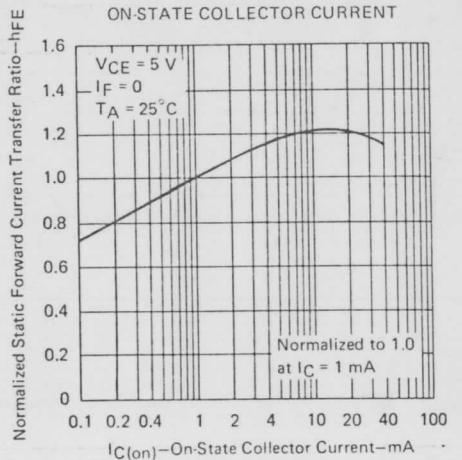


FIGURE 6

INPUT DIODE FORWARD
CONDUCTION CHARACTERISTICS

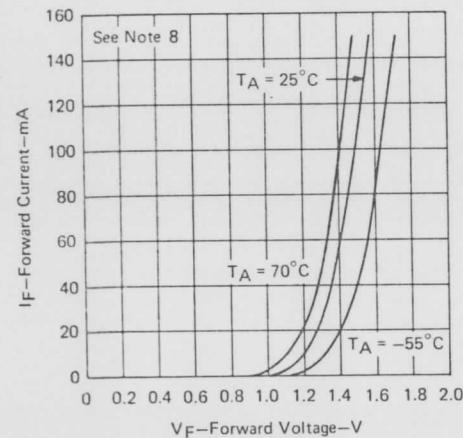


FIGURE 7

COLLECTOR CURRENT
vs
MODULATION FREQUENCY

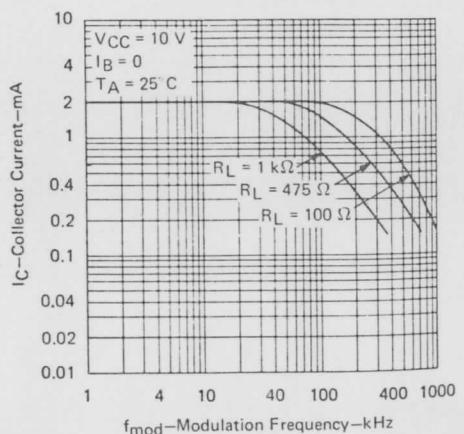


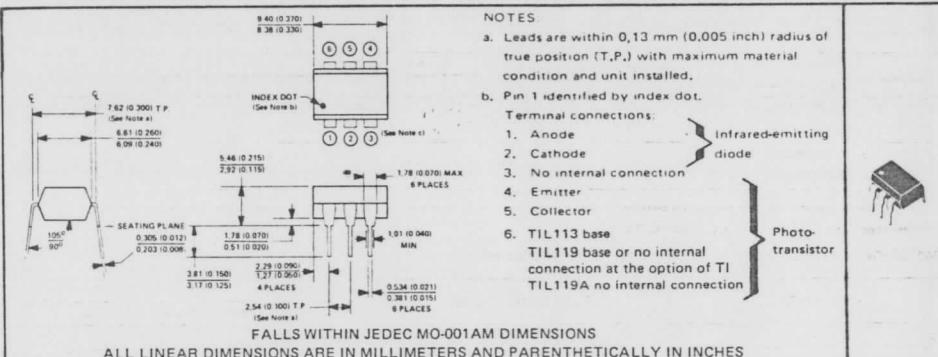
FIGURE 8

NOTE 8: These parameters were measured using pulse techniques. $t_{w} = 1$ ms, duty cycle $\leq 2\%$.

- Gallium Arsenide Diode Infrared Source Optically Coupled to a Silicon N-P-N Darlington-Connected Phototransistor
- High Direct-Current Transfer Ratio . . . 300% Minimum at 10 mA
- High-Voltage Electrical Isolation . . . 1500-Volt Rating
- Plastic Dual-In-Line Package
- Base Lead Provided on TIL113 for Conventional Transistor Biasing
- No Base Lead Connection on TIL119A for High-EMI Environments
- Typical Applications Include Remote Terminal Isolation, SCR and Triac Triggers, Mechanical Relays, and Pulse Transformers

mechanical data

The package consists of a gallium arsenide infrared-emitting diode and an n-p-n silicon darlington-connected phototransistor mounted on a 6-lead frame encapsulated within an electrically nonconductive plastic compound. The case will withstand soldering temperature with no deformation and device performance characteristics remain stable when operated in high-humidity conditions. Unit weight is approximately 0.52 grams.



absolute maximum ratings at 25 °C free-air temperature (unless otherwise noted)

Input-to-Output Voltage	±1.5 kV
Collector-Base Voltage (TIL113)	30 V
Collector-Emitter Voltage (See Note 1)	30 V
Emitter-Collector Voltage	7 V
Emitter-Base Voltage (TIL113)	7 V
Input-Diode Reverse Voltage	3 V
Input-Diode Continuous Forward Current at (or below) 25 °C Free-Air Temperature (See Note 2)	100 mA
Continuous Power Dissipation at (or below) 25 °C Free-Air Temperature:	
Infrared-Emitting Diode (See Note 3)	150 mW
Phototransistor (See Note 4)	150 mW
Total (Infrared-Emitting Diode plus Phototransistor, See Note 5)	250 mW
Storage Temperature Range	-55 °C to 150 °C
Lead Temperature 1.6 mm (1/16 Inch) from Case for 10 Seconds	260 °C

NOTES: 1. This value applies when the base-emitter diode is open-circuited.
2. Derate linearly to 100 °C free-air temperature at the rate of 1.33 mA/°C.
3. Derate linearly to 100 °C free-air temperature at the rate of 2 mW/°C.
4. Derate linearly to 100 °C free-air temperature at the rate of 2 mW/°C.
5. Derate linearly to 100 °C free-air temperature at the rate of 3.33 mW/°C.